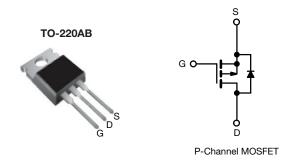


Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-200			
R _{DS(on)} (Ω)	$V_{GS} = -10 \text{ V}$	0.50		
Q _g max. (nC)	44			
Q _{gs} (nC)	7.1			
Q _{gd} (nC)	27			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9640PbF
Lead (Pb)-free and halogen-free	IRF9640PbF-BE3

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unle	ess otherwis	e noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	-200	V	
Gate-source voltage			V_{GS}	± 20	V	
Continuous drain current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		-11	А	
		T _C = 100 °C	I _D	-6.8		
Pulsed drain current ^a			I _{DM}	-44		
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy b			E _{AS}	700	mJ	
Repetitive avalanche current ^a			I _{AR}	-11	А	
Repetitive avalanche energy ^a			E _{AR}	13	mJ	
Maximum power dissipation	$T_C = 2$	25 °C	P_{D}	125	W	
Peak diode recovery dV/dt ^c			dV/dt	-5.0	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^d	For 10 s		-	300		
Mounting toward	6-32 or M3 screw			10	lbf ⋅ in	
Mounting torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = -50 V, starting T_J = 25 °C, L = 8.7 mH, R_q = 25 Ω , I_{AS} = -11 A (see fig. 12)
- c. $I_{SD} \le -11$ A, $dI/dt \le 150$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	=	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							•
Drain-source breakdown voltage	V _{DS}	V _{GS} =	-200	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.2	_	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = -250 μA	-2.0	-	-4.0	V
Gate-source leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
7	,	V _{DS} = -200 V, V _{GS} = 0 V		-	-	-100	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -160 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	-500	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = -10 V	I _D = -6.6 A ^b	-	-	0.50	Ω
Forward transconductance	9fs	V _{DS} =	-50 V, I _D = -6.6 A ^b	4.1	-	-	S
Dynamic							•
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$		-	1200	-	pF
Output capacitance	C _{oss}			-	370	_	
Reverse transfer capacitance	C _{rss}	f = 1.	.0 MHz, see fig. 5	-	81	-	1 .
Total gate charge	Qg		I _D = -11 A, V _{DS} = -160 V, see fig. 6 and 13 ^b	-	-	44	nC
Gate-source charge	Q _{gs}	V _{GS} = -10 V		-	-	7.1	
Gate-drain charge	Q _{gd}	1		-	-	27	
Turn-on delay time	t _{d(on)}		•	-	14	-	
Rise time	t _r	$V_{DD} =$	V _{DD} = -100 V, I _D = -11 A		43	-	ns
Turn-off delay time	t _{d(off)}	$R_g = 9.1 \Omega$, $R_D = 8.6 \Omega$, see fig. 10 b		-	39	_	
Fall time	t _f			-	38	-	
Gate input resistance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	- nH
Internal drain inductance	L _S		package and center of die contact		7.5	-	
Internal source inductance	R _g	f = 1 MHz, open drain		0.3	-	1.7	Ω
Drain-Source Body Diode Characteristic	es						
Continuous source-drain diode current	I _S	showing	MOSFET symbol showing the		-	-11	_
Pulsed diode forward current ^a	I _{SM}	integral reverse p -n junction diode		-	-	-44	A
Body diode voltage	V _{SD}	$T_J = 25$ °C, $I_S = -11$ A, $V_{GS} = 0$ V b		-	-	-5	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = -11 A, dl/dt = 100 A/μs b		-	250	300	ns
Body diode reverse recovery charge	Q _{rr}			-	2.9	3.6	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

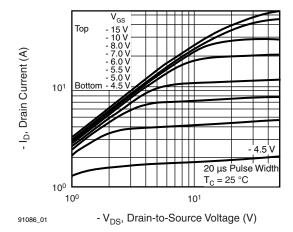


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

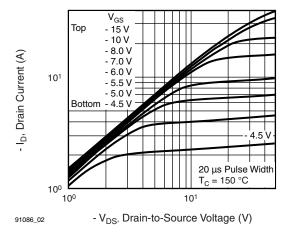


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

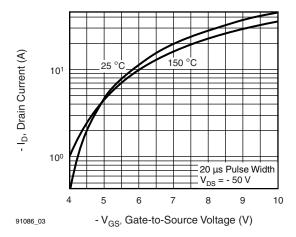


Fig. 3 - Typical Transfer Characteristics

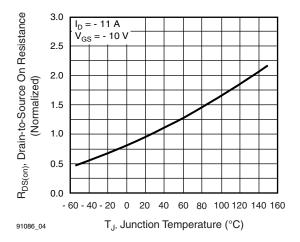


Fig. 4 - Normalized On-Resistance vs. Temperature

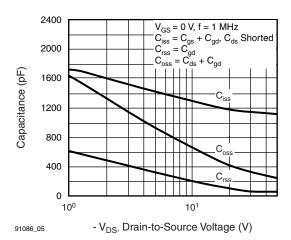


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

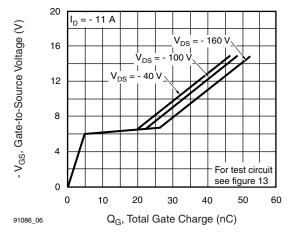


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



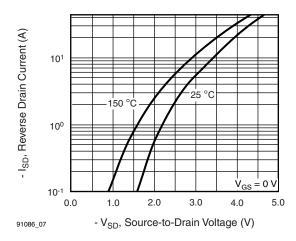


Fig. 7 - Typical Source-Drain Diode Forward Voltage

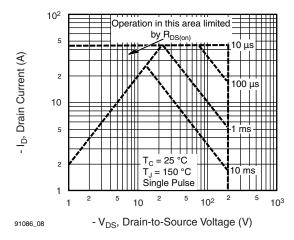


Fig. 8 - Maximum Safe Operating Area

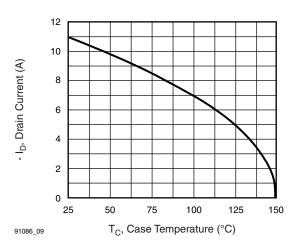


Fig. 9 - Maximum Drain Current vs. Case Temperature

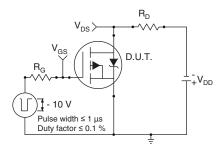


Fig. 10a - Switching Time Test Circuit

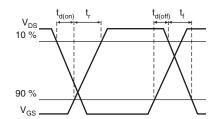


Fig. 10b - Switching Time Waveforms

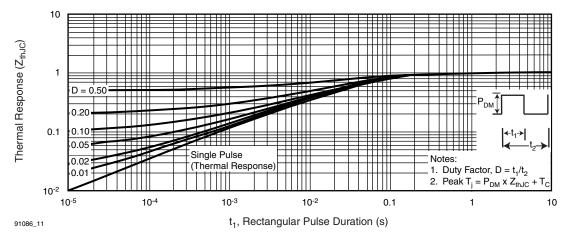


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



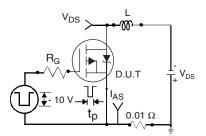


Fig. 12a - Unclamped Inductive Test Circuit

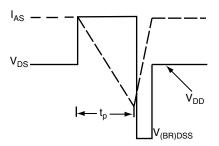


Fig. 12b - Unclamped Inductive Waveforms

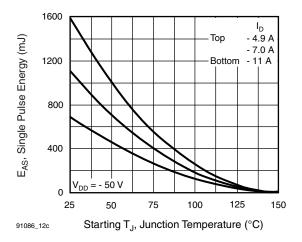


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

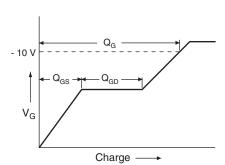


Fig. 13a - Basic Gate Charge Waveform

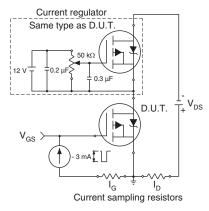
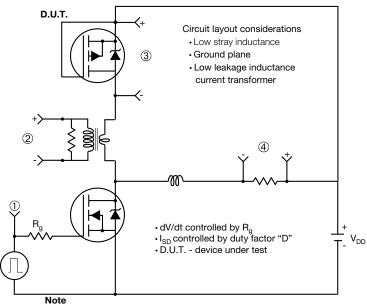


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

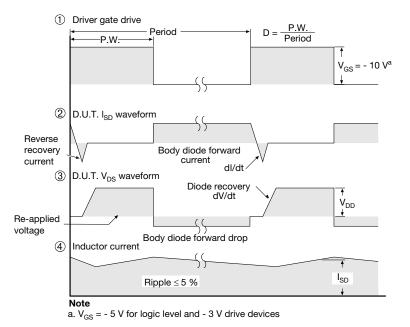


Fig. 14 - For P-Channel

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